

HASO4 NiR

IDEAL WAVEFRONT

SENSOR FOR 1500 - 1600 nm

ADVANCED

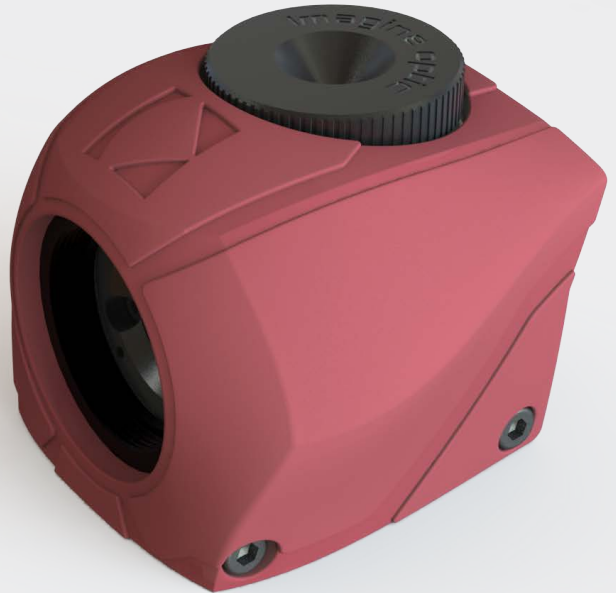
METROLOGY WAVEFRONT SENSOR

COMPACT

AND VERSATILE

EASY

TO USE



The ideal tool for aligning and characterizing optical components or optical systems in the near infrared

A UNIQUE SET OF ADVANTAGES

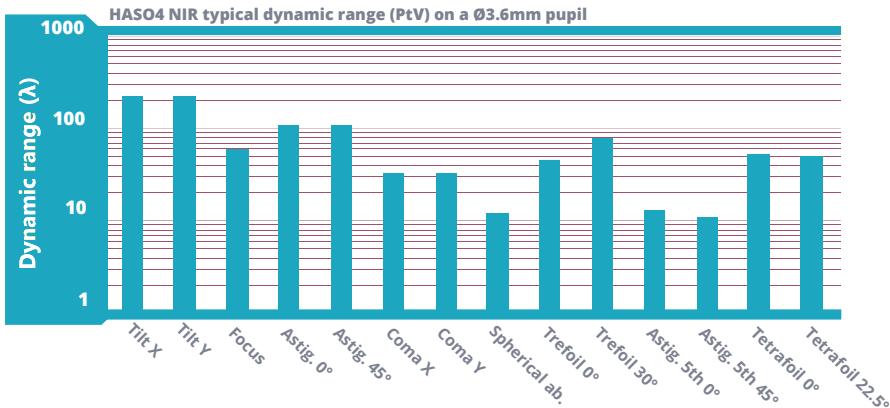
- $\lambda/35$ rms absolute accuracy over 200λ dynamic range
- Calibrated wavelength range: 1500 -1600 nm
- Patented technology for simultaneous and independent measurements of phase and intensity
- 100 Hz acquisition frequency
- External trigger capability
- C-mount compatible entrance aperture
- Easy to deploy with USB 3.0 connectivity
- Bundled with WaveView, the industry's most advanced metrology software
- Compatible with WaveKit (Software Development Kit) in C, MATLAB, and LabVIEW

Contact us for more details: contact@imagine-optic.com or +33 1 64 86 15 60

HASO4 NIR : THE ADVANCED METROLOGY WAVEFRONT SENSOR

Providing outstanding performance, the HASO Wavefront Sensor family is used on the most demanding applications in optical metrology, microscopy and laser diagnostics worldwide. We offer a unique combination of expertise in high quality microlens production, software development and accurate factory calibrations. This allows the HASO4 to provide a level of performance beyond comparison.

- $\lambda/35$ rms absolute accuracy on a huge dynamic range (see the graph below)
- Patented wavefront correction algorithms for intensity beam variations (laser, Gaussian, hyper Gaussian, apodized beams...)
- Measurement up to 64 Zernike polynomials



OUTSTANDING PERFORMANCE EXAMPLES WITH : HASO4 NIR

- Beam collimation with an accuracy better than 30m radius of curvature.
- Control and adjustment of axial laser beam deviation better than 20μrad rms
- Direct wavefront acquisition of converging and diverging F/5 beams
- 3D localization of a focal spot up to 0.5μm rms and 5μm rms for lateral and axial resolution respectively (0.1 NA beam)

SOFTWARE

- WaveView is the most advanced wavefront measurement and analysis software. It offers more than 180 functions and tools optimized for a wide range of highly demanding applications. WaveView development philosophy is based on tens of years of customer's feedback, improving the user experience at each version. Modules dedicated to PSF, Strehl ratio, MTF, M² are available.
- WaveKit is a SDK, providing the basis blocks on which one can build a fully customized software for specific HASO based applications or WaveView data processing routines. WaveKit is available on request.

Operating mode	Full resolution
Aperture dimension	3.6 x 4.5 mm ²
Number of microlenses	32 x 40
Tilt dynamic range	> ± 3 °
Focus dynamic range	±0.018m to ±∞
Repeatability (rms)	< λ/70
Wavefront measurement accuracy in absolute mode (rms)	~ λ/35
Spatial resolution	~ 110 μm
Maximum acquisition frequency	100 Hz
External trigger	TTL signal
Wavelength range	1500-1600 nm
Dimensions / weight	46x57 x 57 mm ³ /150g
Working temperature	15 - 30° C
Interface / Power supply	USB 3.0 / 2.7W via USB
Operating system	Win XP, Win 7 (x86 / x64)